

# DATA SHEET

## **74LV273**

Octal D-type flip-flop with reset;  
positive-edge trigger

Product specification  
Supersedes data of 1997 Apr 07  
IC24 Data Handbook

1998 May 29

## Octal D-type flip-flop with reset; positive edge-trigger

74LV273

## FEATURES

- Wide operating voltage: 1.0 to 5.5V
- Optimized for Low Voltage applications: 1.0 to 3.6V
- Accepts TTL input levels between  $V_{CC} = 2.7V$  and  $V_{CC} = 3.6V$
- Typical  $V_{OLP}$  (output ground bounce)  $< 0.8V$  @  $V_{CC} = 3.3V$ ,  $T_{amb} = 25^{\circ}C$
- Typical  $V_{OHV}$  (output  $V_{OH}$  undershoot)  $> 2V$  @  $V_{CC} = 3.3V$ ,  $T_{amb} = 25^{\circ}C$
- Ideal buffer for MOS microprocessor or memory
- Common clock and master reset
- Output capability: standard
- $I_{CC}$  category: MSI

## DESCRIPTION

The 74LV273 is a low-voltage Si-gate CMOS device and is pin and function compatible with the 74HC/HCT273.

The 74LV273 has eight edge-triggered, D-type flip-flops with individual D inputs and Q outputs. The common clock (CP) and master reset ( $\overline{MR}$ ) inputs load and reset (clear) all flip-flops simultaneously. The state of each D input, one set-up time before the LOW-to-HIGH clock transition, is transferred to the corresponding output ( $Q_n$ ) of the flip-flop.

All outputs will be forced LOW independently of clock or data inputs by a LOW voltage level on the  $\overline{MR}$  input.

The device is useful for applications where the true output only is required and the clock and master reset are common to all storage elements.

## QUICK REFERENCE DATA

GND = 0V;  $T_{amb} = 25^{\circ}C$ ;  $t_r = t_f \leq 2.5$  ns

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
$t_{PHL}/t_{PLH}$	Propagation delay CP to $Q_n$ ; $\overline{MR}$ to $Q_n$	$C_L = 15pF$ $V_{CC} = 3.3V$	12 13	ns
$f_{max}$	Maximum clock frequency		110	MHz
$C_I$	Input capacitance		3.5	pF
$C_{PD}$	Power dissipation capacitance per flip-flop	Notes 1 and 2	20	pF

## NOTES:

1.  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ )  
 $P_D = C_{PD} \times V_{CC}^2 \times f_i + \sum (C_L \times V_{CC}^2 \times f_o)$  where:  
 $f_i$  = input frequency in MHz;  $C_L$  = output load capacitance in pF;  
 $f_o$  = output frequency in MHz;  $V_{CC}$  = supply voltage in V;  
 $\sum (C_L \times V_{CC}^2 \times f_o)$  = sum of the outputs.
2. The condition is  $V_I = GND$  to  $V_{CC}$

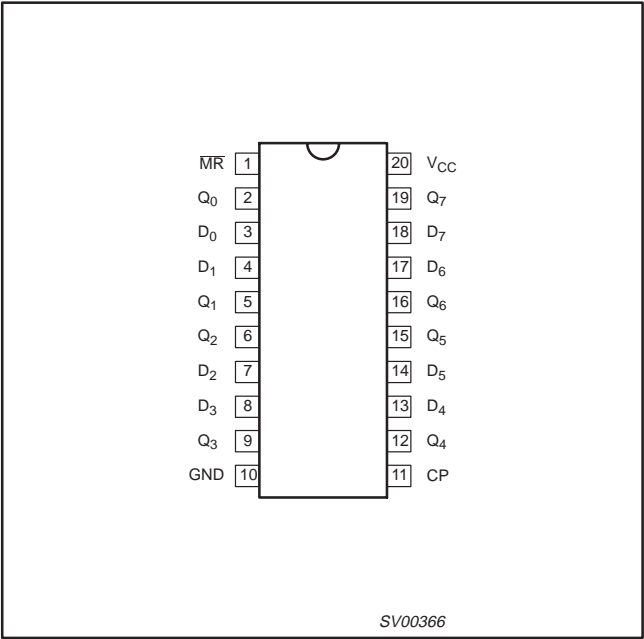
## ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	PKG. DWG. #
20-Pin Plastic DIL	$-40^{\circ}C$ to $+125^{\circ}C$	74LV273 N	74LV273 N	SOT146-1
20-Pin Plastic SO	$-40^{\circ}C$ to $+125^{\circ}C$	74LV273 D	74LV273 D	SOT163-1
20-Pin Plastic SSOP Type II	$-40^{\circ}C$ to $+125^{\circ}C$	74LV273 DB	74LV273 DB	SOT339-1
20-Pin Plastic TSSOP	$-40^{\circ}C$ to $+125^{\circ}C$	74LV273 PW	74LV273PW DH	SOT360-1

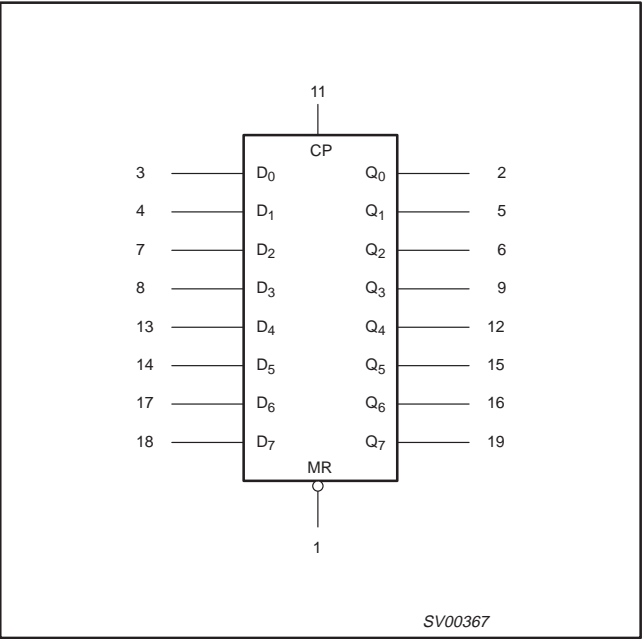
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PIN CONFIGURATION



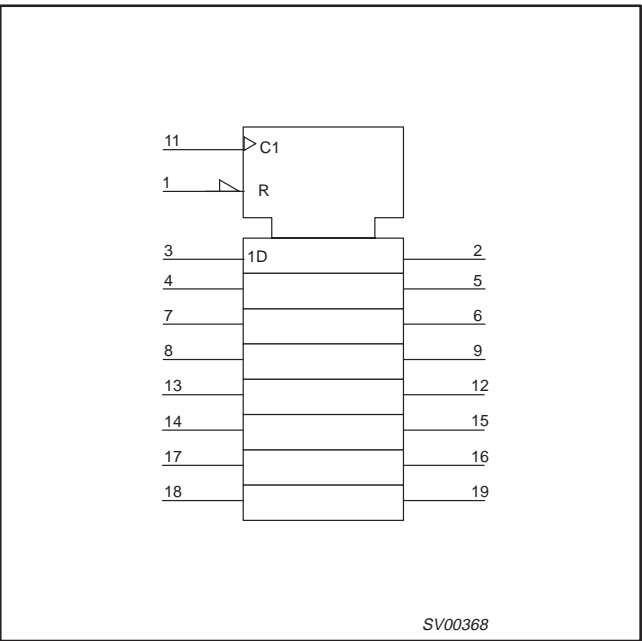
LOGIC SYMBOL



PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
1	MR	Master reset input (active-LOW)
2, 5, 6, 9, 12, 15, 16, 19	Q <sub>0</sub> to Q <sub>7</sub>	Flip-flop outputs
3, 4, 7, 8, 13, 14, 17, 18	D <sub>0</sub> to D <sub>7</sub>	Data inputs
10	GND	Ground (0V)
11	CP	Clock input (LOW-to-HIGH, edge-triggered)
20	V <sub>CC</sub>	Positive supply voltage

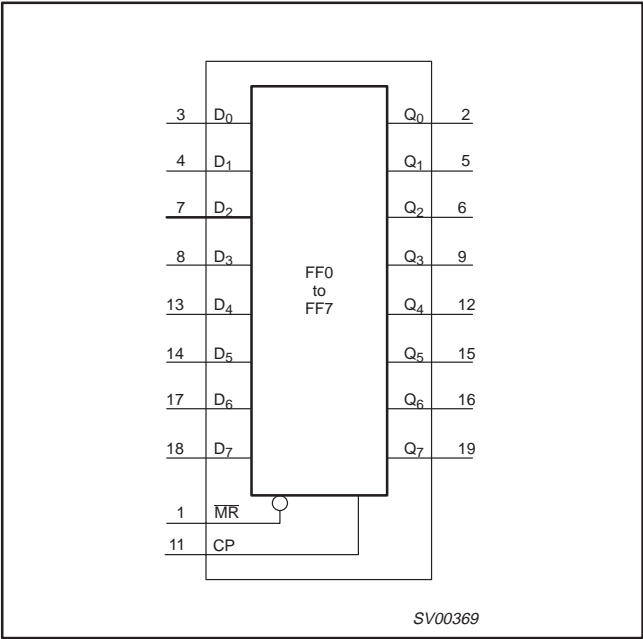
LOGIC SYMBOL (IEEE/IEC)



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FUNCTIONAL DIAGRAM



FUNCTION TABLE

OPERATING MODES	INPUTS			OUTPUTS
	MR	CP	D <sub>n</sub>	Q <sub>0</sub> to Q <sub>7</sub>
Reset (clear)	L	X	X	L
Load ('1')	H	↑	h	H
Load ('0')	H	↑	l	L

- H = HIGH voltage level
- h = HIGH voltage level one set-up time prior to the LOW-to-HIGH CP transition
- L = LOW voltage level
- l = LOW voltage level one set-up time prior to the LOW-to-HIGH CP transition
- ↑ = LOW-to-HIGH clock transition
- X = Don't care

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP.	MAX	UNIT
V <sub>CC</sub>	DC supply voltage	See Note1	1.0	3.3	5.5	V
V <sub>I</sub>	Input voltage		0	–	V <sub>CC</sub>	V
V <sub>O</sub>	Output voltage		0	–	V <sub>CC</sub>	V
T <sub>amb</sub>	Operating ambient temperature range in free air	See DC and AC characteristics	–40 –40		+85 +125	°C
t <sub>r</sub> , t <sub>f</sub>	Input rise and fall times	V <sub>CC</sub> = 1.0V to 2.0V V <sub>CC</sub> = 2.0V to 2.7V V <sub>CC</sub> = 2.7V to 3.6V V <sub>CC</sub> = 3.6V to 5.5V	– – – –	– – – –	500 200 100 50	ns/V

**NOTES:**  
1. The LV is guaranteed to function down to V<sub>CC</sub> = 1.0V (input levels GND or V<sub>CC</sub>); DC characteristics are guaranteed from V<sub>CC</sub> = 1.2V to V<sub>CC</sub> = 5.5V.

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**ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>**

In accordance with the Absolute Maximum Rating System (IEC 134)

Voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
$V_{CC}$	DC supply voltage		-0.5 to +7.0	V
$\pm I_{IK}$	DC input diode current	$V_I < -0.5$ or $V_I > V_{CC} + 0.5V$	20	mA
$\pm I_{OK}$	DC output diode current	$V_O < -0.5$ or $V_O > V_{CC} + 0.5V$	50	mA
$\pm I_O$	DC output source or sink current – standard outputs	$-0.5V < V_O < V_{CC} + 0.5V$	25	mA
$\pm I_{GND},$ $\pm I_{CC}$	DC $V_{CC}$ or GND current for types with –standard outputs		50	mA
$T_{stg}$	Storage temperature range		-65 to +150	°C
$P_{TOT}$	Power dissipation per package –plastic DIL –plastic mini-pack (SO) –plastic shrink mini-pack (SSOP and TSSOP)	for temperature range: -40 to +125°C above +70°C derate linearly with 12mW/K above +70°C derate linearly with 8 mW/K above +60°C derate linearly with 5.5 mW/K	750 500 400	mW

**NOTES:**

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

**DC CHARACTERISTICS FOR THE LV FAMILY**

Over recommended operating conditions voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS					UNIT
			-40°C to +85°C			-40°C to +125°C		
			MIN	TYP <sup>1</sup>	MAX	MIN	MAX	
V <sub>IH</sub>	HIGH level Input voltage	V <sub>CC</sub> = 1.2V	0.9			0.9		V
		V <sub>CC</sub> = 2.0V	1.4			1.4		
		V <sub>CC</sub> = 2.7 to 3.6V	2.0			2.0		
		V <sub>CC</sub> = 4.5 to 5.5V	0.7*V <sub>CC</sub>			0.7*V <sub>CC</sub>		
V <sub>IL</sub>	LOW level Input voltage	V <sub>CC</sub> = 1.2V			0.3		0.3	V
		V <sub>CC</sub> = 2.0V			0.6		0.6	
		V <sub>CC</sub> = 2.7 to 3.6V			0.8		0.8	
		V <sub>CC</sub> = 4.5 to 5.5			0.3*V <sub>CC</sub>		0.3*V <sub>CC</sub>	
V <sub>OH</sub>	HIGH level output voltage; all outputs	V <sub>CC</sub> = 1.2V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; -I <sub>O</sub> = 100μA		1.2				V
		V <sub>CC</sub> = 2.0V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; -I <sub>O</sub> = 100μA	1.8	2.0		1.8		
		V <sub>CC</sub> = 2.7V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; -I <sub>O</sub> = 100μA	2.5	2.7		2.5		
		V <sub>CC</sub> = 3.0V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; -I <sub>O</sub> = 100μA	2.8	3.0		2.8		
		V <sub>CC</sub> = 4.5V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; -I <sub>O</sub> = 100μA	4.3	4.5		4.3		
	HIGH level output voltage; STANDARD outputs	V <sub>CC</sub> = 3.0V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; -I <sub>O</sub> = 6mA	2.40	2.82		2.20		V
		V <sub>CC</sub> = 4.5V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; -I <sub>O</sub> = 12mA	3.60	4.20		3.50		
V <sub>OL</sub>	LOW level output voltage; all outputs	V <sub>CC</sub> = 1.2V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = 100μA		0				V
		V <sub>CC</sub> = 2.0V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = 100μA		0	0.2		0.2	
		V <sub>CC</sub> = 2.7V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = 100μA		0	0.2		0.2	
		V <sub>CC</sub> = 3.0V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = 100μA		0	0.2		0.2	
		V <sub>CC</sub> = 4.5V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = 100μA		0	0.2		0.2	
	LOW level output voltage; STANDARD outputs	V <sub>CC</sub> = 3.0V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = 6mA		0.25	0.40		0.50	V
		V <sub>CC</sub> = 4.5V; V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = 12mA		0.35	0.55		0.65	

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**DC CHARACTERISTICS FOR THE LV FAMILY (Continued)**

Over recommended operating conditions voltages are referenced to GND (ground = 0V)

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS					UNIT
			-40°C to +85°C			-40°C to +125°C		
I <sub>I</sub>	Input leakage current	V <sub>CC</sub> = 5.5V; V <sub>I</sub> = V <sub>CC</sub> or GND			1.0		1.0	μA
I <sub>CC</sub>	Quiescent supply current; MSI	V <sub>CC</sub> = 5.5V; V <sub>I</sub> = V <sub>CC</sub> or GND; I <sub>O</sub> = 0			20.0		160	μA
ΔI <sub>CC</sub>	Additional quiescent supply current per input	V <sub>CC</sub> = 2.7V to 3.6V; V <sub>I</sub> = V <sub>CC</sub> - 0.6V			500		850	μA

**NOTE:**1. All typical values are measured at  $T_{amb} = 25^\circ C$ .**AC CHARACTERISTICS**GND = 0V;  $t_r = t_f = 2.5ns$ ;  $C_L = 50pF$ ;  $R_L = 1K\Omega$ 

SYMBOL	PARAMETER	WAVEFORM	CONDITION $V_{CC}(V)$	LIMITS -40 to +85 °C			LIMITS -40 to +125 °C		UNIT
				MIN	TYP <sup>1</sup>	MAX	MIN	MAX	
$t_{PHL}/t_{PLH}$	Propagation delay CP to $Q_n$	Figure 1	1.2	—	75	—	—	—	ns
			2.0	—	26	32	—	41	
			2.7	—	19	24	—	30	
			3.0 to 3.6	—	14 <sup>2</sup>	19	—	24	
			4.5 to 5.5	—	—	16	—	20	
$t_{PHL}$	Propagation delay MR to $Q_n$	Figure 2	1.2	—	80	—	—	—	ns
			2.0	—	27	44	—	56	
			2.7	—	20	33	—	41	
			3.0 to 3.6	—	15 <sup>2</sup>	26	—	33	
			4.5 to 5.5	—	—	22	—	28	
$t_W$	Clock pulse width HIGH or LOW	Figure 1	2.0	34	9	—	41	—	ns
			2.7	25	6	—	30	—	
			3.0 to 3.6	20	5 <sup>2</sup>	—	24	—	
$t_W$	Master reset pulse width LOW	Figure 2	2.0	34	10	—	41	—	ns
			2.7	25	8	—	30	—	
			3.0 to 3.6	20	6 <sup>2</sup>	—	24	—	
$t_{rem}$	Removal time MR to CP	Figure 2	1.2	—	-10	—	—	—	ns
			2.0	5	-4	—	5	—	
			2.7	5	-3	—	5	—	
			3.0 to 3.6	5	-2 <sup>2</sup>	—	5	—	
$t_{su}$	Set-up time $D_n$ to CP	Figure 3	1.2	—	20	—	—	—	ns
			2.0	22	7	—	26	—	
			2.7	16	5	—	19	—	
			3.0 to 3.6	13	4 <sup>2</sup>	—	15	—	
$t_h$	Hold time $D_n$ to CP	Figure 3	1.2	—	-10	—	—	—	ns
			2.0	5	-4	—	5	—	
			2.7	5	-3	—	5	—	
			3.0 to 3.6	5	-2 <sup>2</sup>	—	5	—	
$f_{max}$	Maximum clock pulse frequency	Figure 1	2.0	14	40	—	12	—	MHz
			2.7	19	75	—	16	—	
			3.0 to 3.6	24	100 <sup>2</sup>	—	20	—	

**NOTE:**1. Unless otherwise stated, all typical values are at  $T_{amb} = 25^\circ C$ .2. Typical value measured at  $V_{CC} = 3.3V$ .3. Typical value measured at  $V_{CC} = 5.0V$ .

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AC WAVEFORMS

$V_M = 1.5V$  at  $V_{CC} \geq 2.7V \leq 3.6V$   
 $V_M = 0.5V * V_{CC}$  at  $V_{CC} < 2.7V$  and  $\geq 4.5V$   
 $V_{OL}$  and  $V_{OH}$  are the typical output voltage drop that occur with the output load.

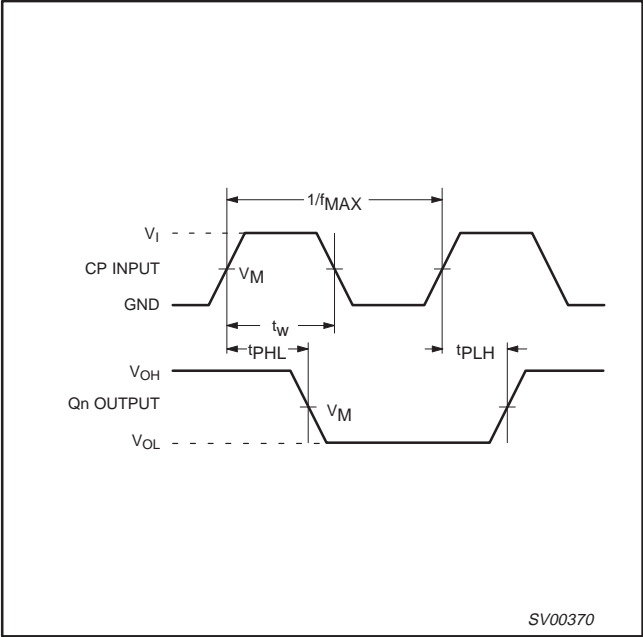


Figure 1. The clock (CP) to output (Q<sub>n</sub>) propagation delays, the clock pulse width and the maximum clock pulse frequency

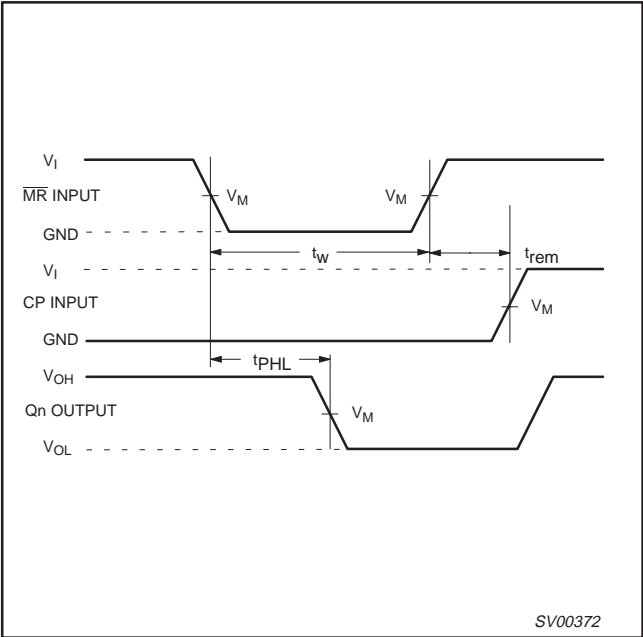


Figure 2. The master reset ( $\overline{MR}$ ) pulse width, the master reset to output (Q<sub>n</sub>) propagations delay and the master reset to clock (CP) removal time

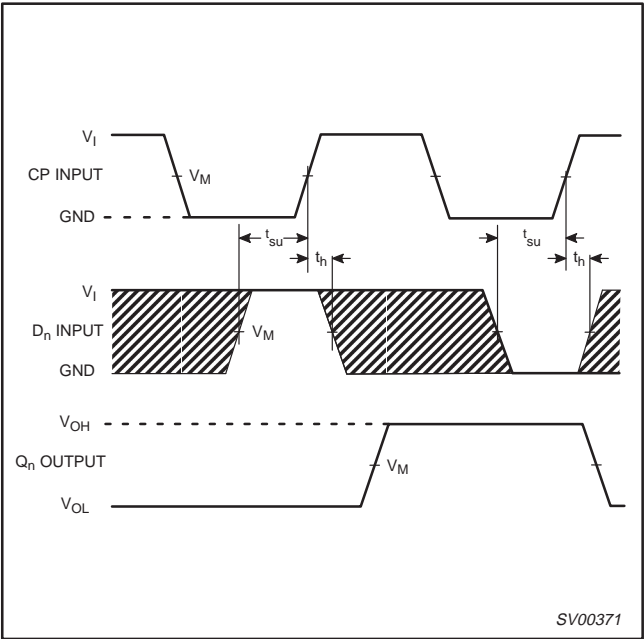


Figure 3. Data set-up and hold times for the data input (D<sub>n</sub>)

**NOTE:**  
The shaded areas indicate when the input is permitted to change for predictable output performance.

TEST CIRCUIT

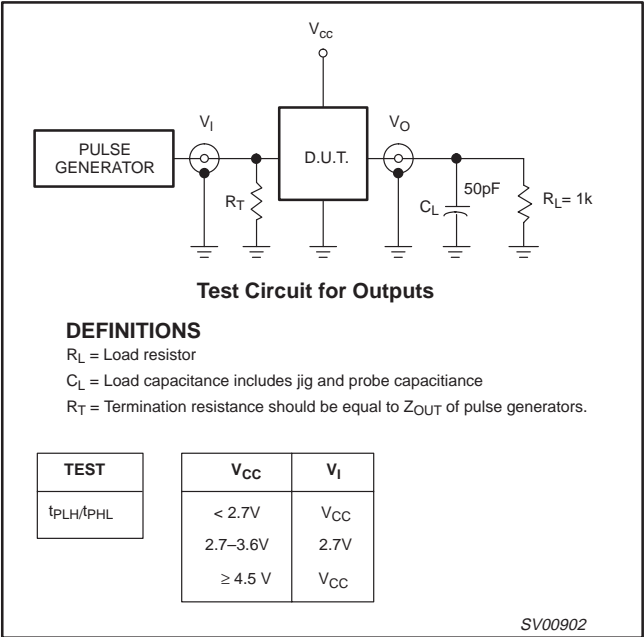


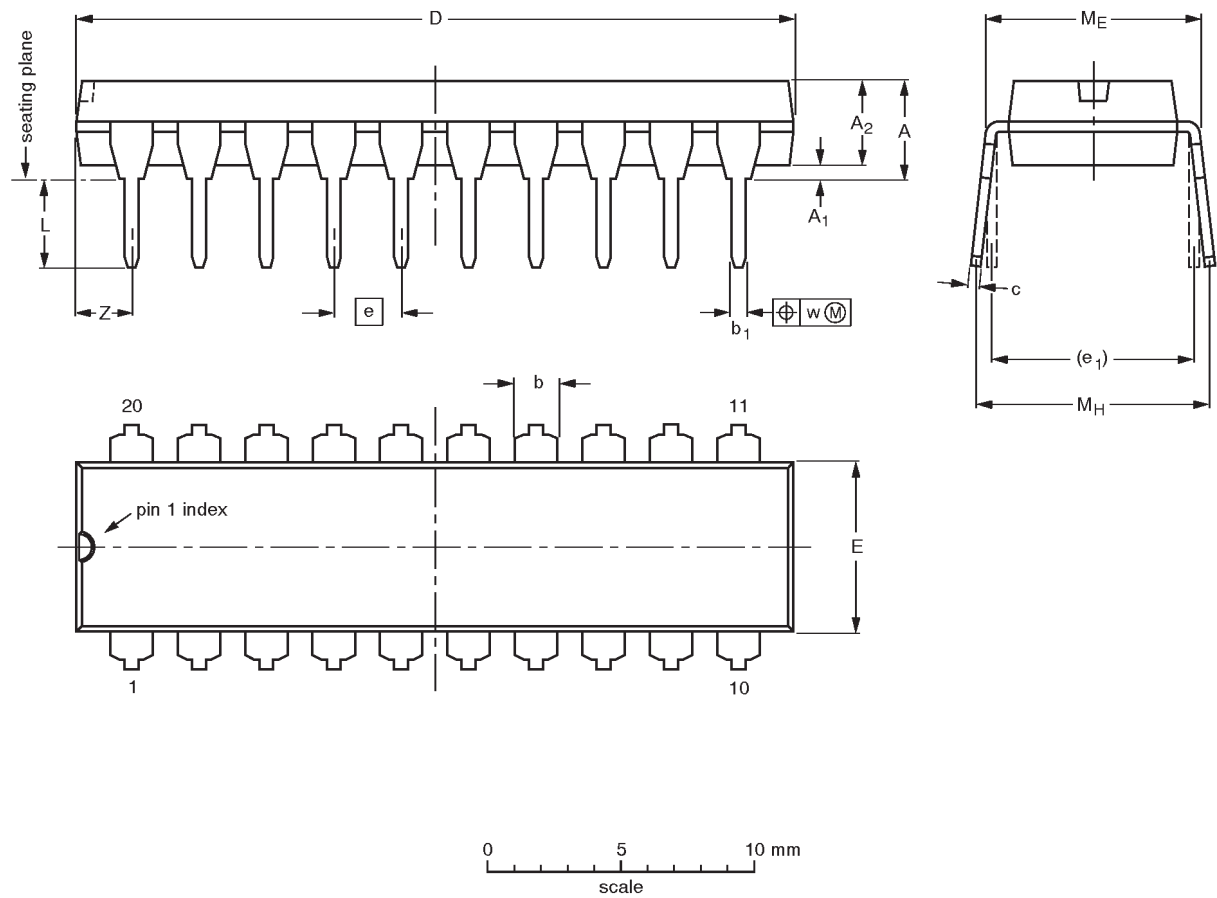
Figure 4. Load circuitry for switching times

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DIP20: plastic dual in-line package; 20 leads (300 mil)

SOT146-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	c	D <sup>(1)</sup>	E <sup>(1)</sup>	e	e <sub>1</sub>	L	M <sub>E</sub>	M <sub>H</sub>	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.0
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

Note  
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT146-1			SC603			92-11-17 95-05-24

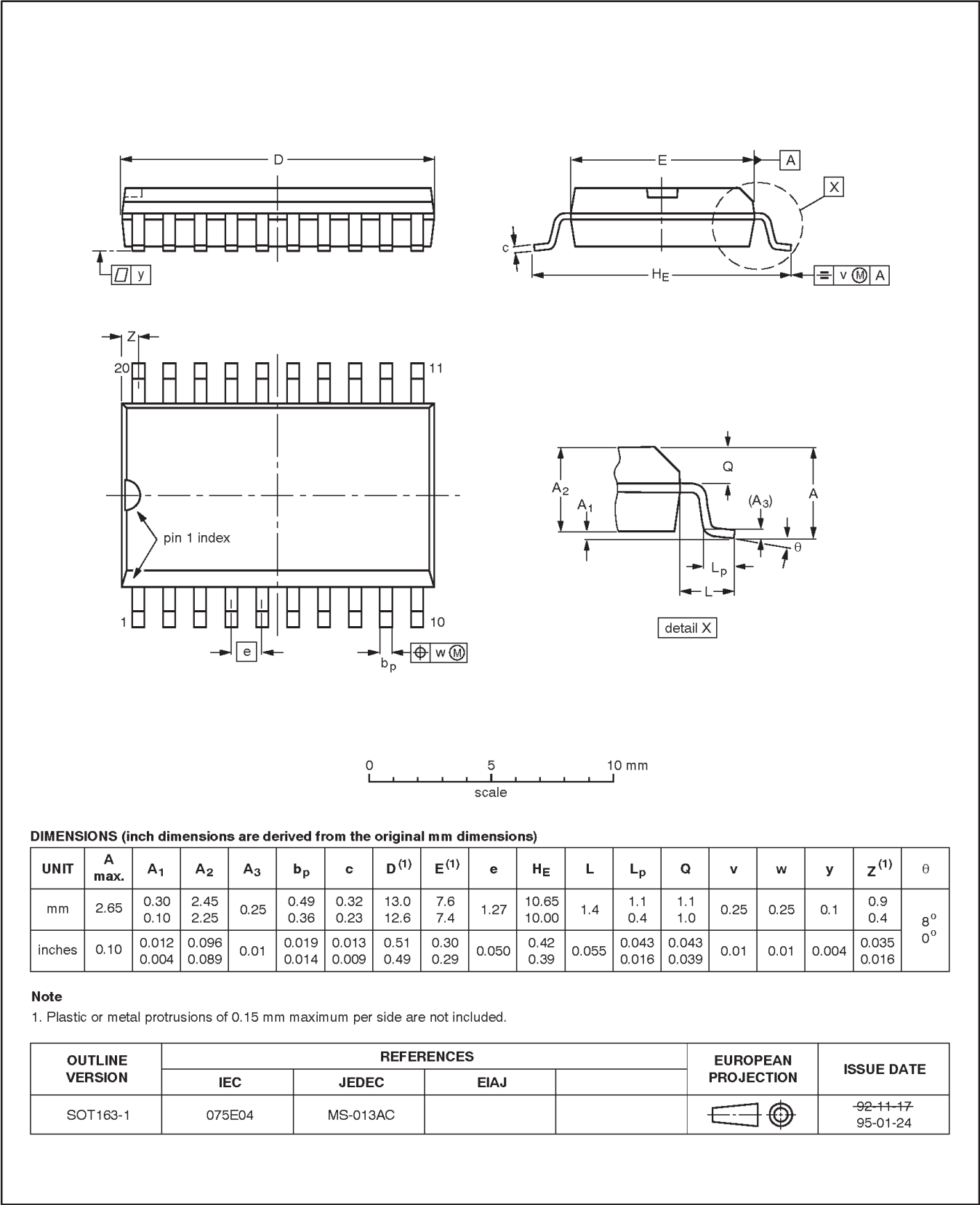


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SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1

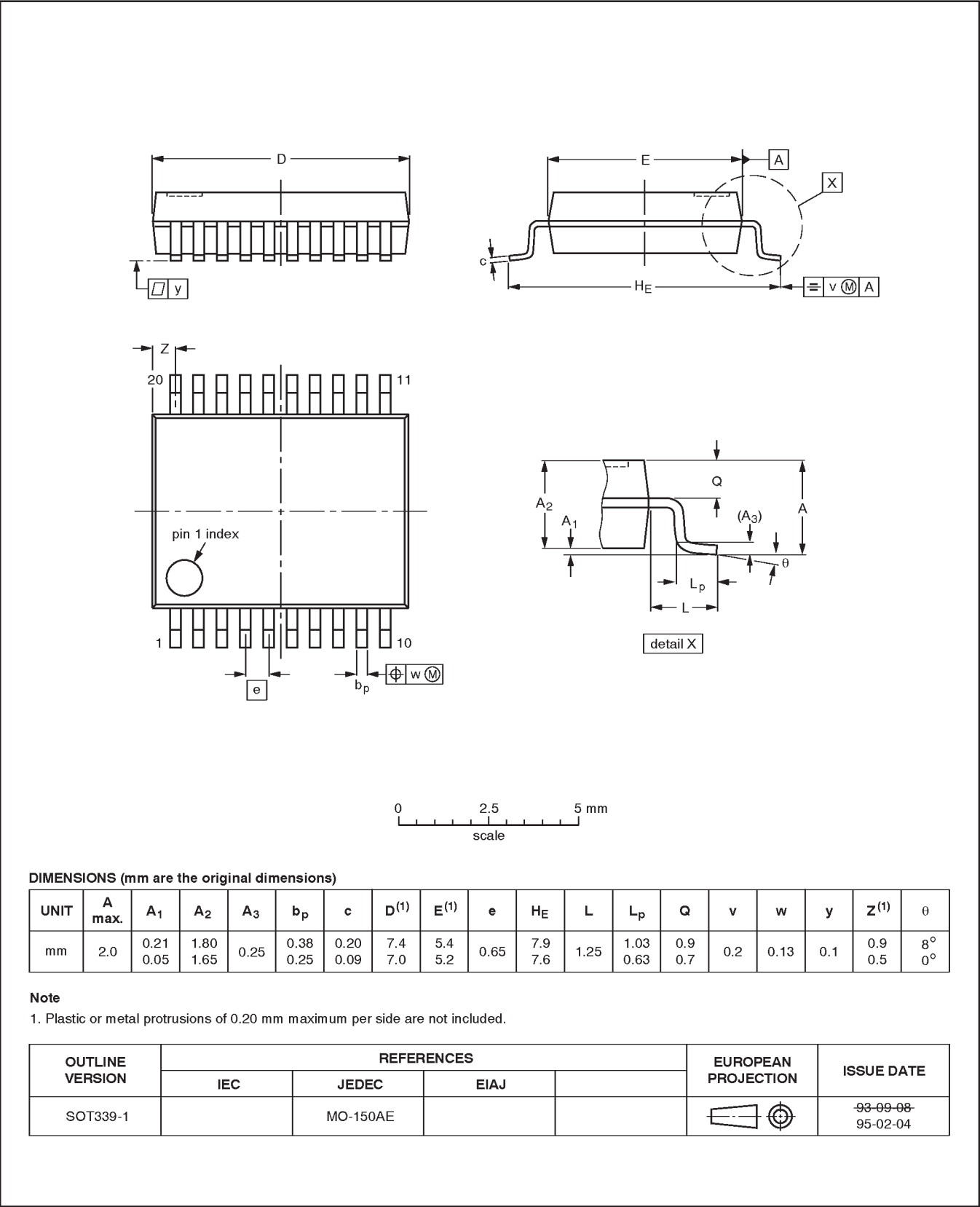


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SSOP20: plastic shrink small outline package; 20 leads; body width 5.3 mm

SOT339-1

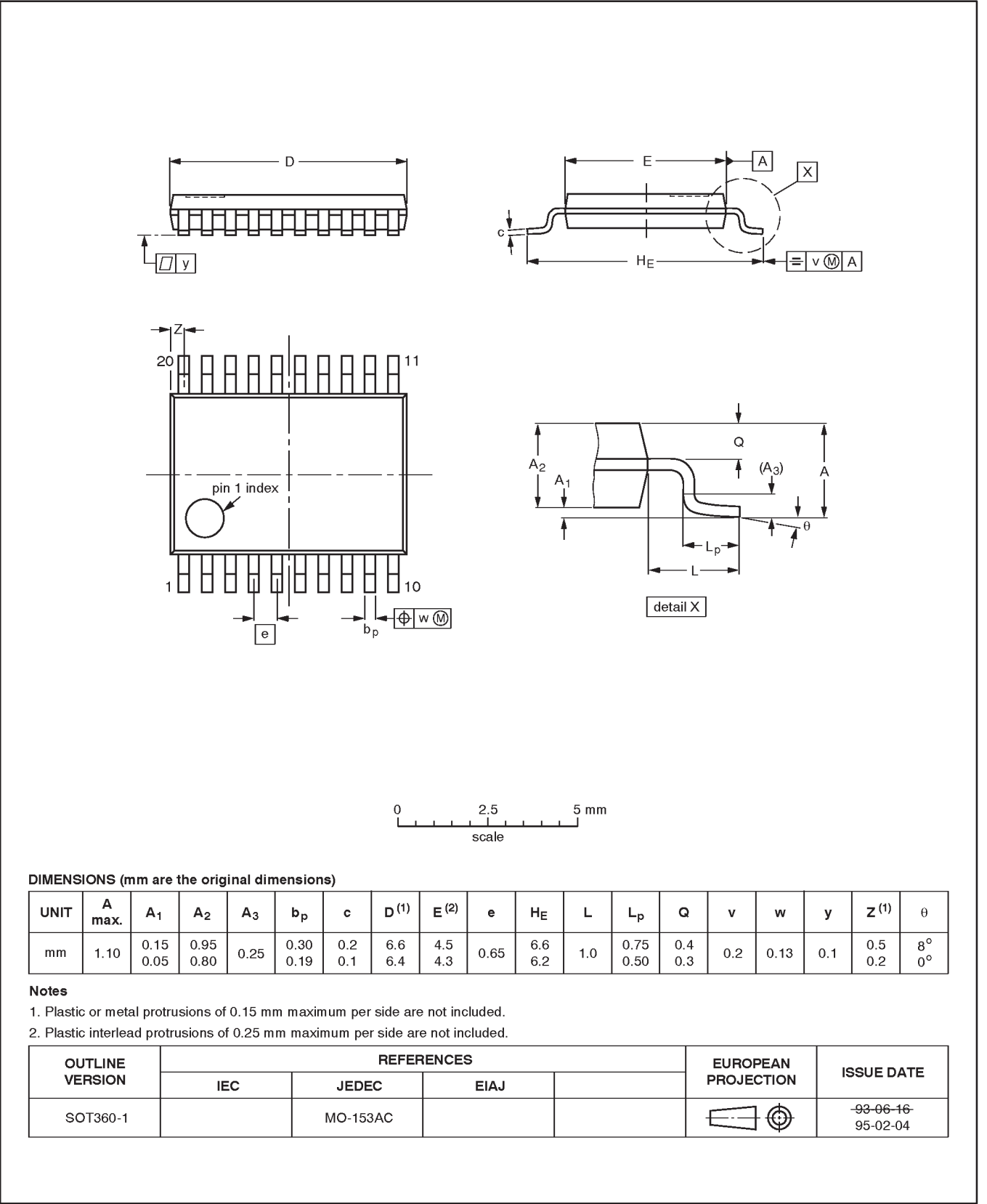


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TSSOP20: plastic thin shrink small outline package; 20 leads; body width 4.4 mm

SOT360-1



Octal D–type flip–flop with reset; positive edge–trigger

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DEFINITIONS		
Data Sheet Identification	Product Status	Definition
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.
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